Se	arch N	otes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/539,652	BUREAU, COME	
Examiner	Art Unit	
Laura M. Lee	3724	

SEARCHED			
Class	Subclass	Date	Examiner
83	102.1, 75.5, 364- 365, 367	6/19/2007	LML
144	357,242.1	6/19/2007	LML
144	248.5	6/19/2007	LML
144	250.2	6/19/2007	LML
· 144	215.2	6/19/2007	٧
144	253.7	6/19/2007	LML
144	250.13	6/19/2007	LML
144	250.15	6/19/2007	LML
144	246.2	6/19/2007	LML
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
East Search, Text Search, Inventor Name Search, Considered IDS, Considered Intenational Search Report	6/19/2007	LML
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